

Notes on Stein's Method (221201)

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This note will contain some core concepts required to understand the Stein's method.

Contents

1	Kernelized Stein discrepancy	1
1.1	Background [Liu, 2016]	1
1.2	Stein's identity	2
1.3	(Kernelized) Stein discrepancy	2
2	Stein Variational Gradient Descent	4
2.1	Multi-dimensional KSD	4
2.2	Variational inference with smooth transforms	5
3	Amortized SVGD	6
A	The reproducing property	6
B	Lemmas	6
C	Introduction to measure theory	6

1 Kernelized Stein discrepancy

1.1 Background [Liu, 2016]

Given data: $\{\mathbf{x}_i\}_{i=1}^n$, and model: $p(\mathbf{x})$. We want some discrepancy measures that can tell the consistency between data and models. They have wide applications in:

- Model evaluation: $\{\mathbf{x}_i\}_{i=1}^n$ and $p(\mathbf{x})$ are both given, (discrepancy measures tell us how well a model fits data).
- Frequentist parameter learning: $\{\mathbf{x}_i\}_{i=1}^n$ is given and we optimize $p(\mathbf{x})$, (find the model that minimizes the discrepancy with data).

- Sampling for Bayesian inference: $p(\mathbf{x})$ is given and we want to optimize $\{\mathbf{x}_i\}_{i=1}^n$, (find a set of points ("data") to approximate the posterior distribution).

The discrepancy measure should be tractably computable, the famous KL divergence $D_{\text{KL}}[p(\mathbf{x}) \parallel q(\mathbf{x})] = \mathbb{E}_{p(\mathbf{x})} \left[\log \frac{p(\mathbf{x})}{q(\mathbf{x})} \right]$ is not ideal for this case because:

- $\log q(\mathbf{x})$ is required, however, a lot models are only known up to a normalization constant, e.g. energy based models (EBMs): $q(\mathbf{x}) = \exp(-E(\mathbf{x})) / Z$, where $Z = \int_{\mathcal{X}} \exp(-E(\mathbf{x})) d\mathbf{x}$ is the normalization constant.
- It is not straightforward to talk about the KL divergence $D_{\text{KL}}(\{\mathbf{x}_i\}_{i=1}^n \parallel p(\mathbf{x}))$ between a set of data points (drawn from a distribution q) and the model, since in this way we have to do density estimation (or entropy estimation) for $\{\mathbf{x}_i\}_{i=1}^n$.

Kernelized Stein discrepancy (KSD) [Liu et al., 2016] provides a convenient way to directly assess the compatibility of data-model pairs, even for models with intractable normalization constant.

For simplicity, in the following $f(\cdot)$ is always referred to a scalar-valued function, and the data points \mathbf{x} 's are also scalars.

1.2 Stein's identity

For distributions with smooth density $p(\mathbf{x})$ and function $f(\mathbf{x})$ (supported on \mathbb{R}) that satisfies $\lim_{\|\mathbf{x}\| \rightarrow \infty} p(\mathbf{x})f(\mathbf{x}) = 0$, we have:

$$\mathbb{E}_{p(\mathbf{x})} [\nabla_{\mathbf{x}} \log p(\mathbf{x}) f(\mathbf{x}) + \nabla_{\mathbf{x}} f(\mathbf{x})] = 0, \quad \forall f. \quad (1)$$

Proof.

$$\begin{aligned} \int p(\mathbf{x}) [\nabla_{\mathbf{x}} \log p(\mathbf{x}) f(\mathbf{x}) + \nabla_{\mathbf{x}} f(\mathbf{x})] d\mathbf{x} &= \int [\nabla_{\mathbf{x}} p(\mathbf{x}) f(\mathbf{x}) + p(\mathbf{x}) \nabla_{\mathbf{x}} f(\mathbf{x})] d\mathbf{x} \\ &= \int \nabla_{\mathbf{x}} [f(\mathbf{x}) p(\mathbf{x})] d\mathbf{x} \\ &= \lim_{\mathbf{x} \rightarrow \infty} p(\mathbf{x}) f(\mathbf{x}) - \lim_{\mathbf{x} \rightarrow -\infty} p(\mathbf{x}) f(\mathbf{x}) \\ &= 0. \end{aligned} \quad (2)$$

□

Here we define $\mathcal{A}_p f(\mathbf{x}) = \nabla_{\mathbf{x}} \log p(\mathbf{x}) f(\mathbf{x}) + \nabla_{\mathbf{x}} f(\mathbf{x})$, where \mathcal{A}_p is called the *Stein operator*. And we say that a function $f : \mathcal{X} \rightarrow \mathbb{R}$ is in the *Stein class* of p if f is smooth and satisfies:

$$\int_{\mathbf{x} \in \mathcal{X}} \nabla_{\mathbf{x}} (f(\mathbf{x}) p(\mathbf{x})) d\mathbf{x} = 0. \quad (3)$$

1.3 (Kernelized) Stein discrepancy

Consider $\mathbb{E}_q [\mathcal{A}_p f(\mathbf{x})] = \mathbb{E}_q [\mathcal{A}_p f(\mathbf{x})] - \mathbb{E}_q [\mathcal{A}_q f(\mathbf{x})] = \mathbb{E}_{q(\mathbf{x})} [f(\mathbf{x}) (\nabla_{\mathbf{x}} \log p(\mathbf{x}) - \nabla_{\mathbf{x}} \log q(\mathbf{x}))]$ (the equation holds because of Lemma 1). In this way, Stein's identity provides a mechanism to compare two different distributions. It is convenient to consider the most discriminant f that maximizes the violation of Stein's identity, this leads to the notion of Stein discrepancy for measuring the difference between two distributions p and q :

$$\sqrt{S(q, p)} = \max_{f \in \mathcal{F}} \mathbb{E}_{q(\mathbf{x})} [\mathcal{A}_p f(\mathbf{x})], \quad (4)$$

where \mathcal{F} is a proper set of functions that we optimize over.

When f can be represented as a linear combination $f(\cdot) = \sum_i w_i f_i(\cdot)$ of a set of **known** basis functions $f_i(\cdot)$, with unknown coefficients w_i ([give an example of Fourier series here](#)). In this case we have:

$$\begin{aligned}\mathbb{E}_q[\mathcal{A}_p f] &= \mathbb{E}_{\mathbf{x} \sim q} \left[\mathcal{A}_p \sum_i w_i f_i(\mathbf{x}) \right] \\ &= \sum_i w_i \beta_i,\end{aligned}\tag{5}$$

where $\beta_i = \mathbb{E}_{q(\mathbf{x})} [\mathcal{A}_p f_i(\mathbf{x})]$, which is a fixed scalar when \mathbf{x} is a scalar. Then the optimization problem delivered in equation 4 becomes to:

$$\max_{\mathbf{w}} \sum_i w_i \beta_i, \quad s.t. \quad \|\mathbf{w}\| \leq 1,\tag{6}$$

and the optimal solution with closed form can be easily got as $w_i^* = \beta_i / \|\beta_i\|$.

Kernelized Stein discrepancy (KSD) takes \mathcal{F} to be the unit ball of a reproducing kernel Hilbert space (RKHS) with kernel $k(\cdot, \cdot)$. (The RKHS \mathcal{H} related to $k(\cdot, \cdot)$ contains functions of form $f(\cdot) = \sum_i w_i k(\mathbf{x}_i, \cdot)$. **Q: what is \mathbf{x}_i ?** **A: related to the reproducing property.**) And KSD is defined as:

$$\sqrt{S(q, p)} = \max_{f \in \mathcal{H}} \mathbb{E}_{q(\mathbf{x})} [\mathcal{A}_p f(\mathbf{x})], \quad s.t. \quad \|f\|_{\mathcal{H}} \leq 1.\tag{7}$$

To use a RKHS \mathcal{H} as \mathcal{F} , we should make sure that $\forall f \in \mathcal{H}$ is in the *Stein class* of p , and this is carefully discussed in Section 3 of [Liu et al., 2016], in the following we simply assume $k(\mathbf{x}, \cdot)$ and $k(\cdot, \mathbf{x})$ are in the *Stein class* of p for any fixed \mathbf{x} .

Our goal is to derive a computational tractable closed form solution to equation 7. First, by the **reproducing property of RKHS** [Sejdinovic and Gretton, 2012], we have:

$$f(\mathbf{x}) = \langle f(\cdot), k(\mathbf{x}, \cdot) \rangle_{\mathcal{H}},\tag{8}$$

$$\nabla_{\mathbf{x}} f(\mathbf{x}) = \langle f(\cdot), \nabla_{\mathbf{x}} k(\mathbf{x}, \cdot) \rangle_{\mathcal{H}},\tag{9}$$

with the reproducing property and the definition of Stein's operator, we have:

$$\mathbb{E}_{q(\mathbf{x})} [\mathcal{A}_p f(\mathbf{x})] = \mathbb{E}_{q(\mathbf{x})} [\nabla_{\mathbf{x}} \log p(\mathbf{x}) f(\mathbf{x}) + \nabla_{\mathbf{x}} f(\mathbf{x})]\tag{10}$$

$$= \mathbb{E}_{q(\mathbf{x})} [\nabla_{\mathbf{x}} \log p(\mathbf{x}) \langle f(\cdot), k(\mathbf{x}, \cdot) \rangle_{\mathcal{H}} + \langle f(\cdot), \nabla_{\mathbf{x}} k(\mathbf{x}, \cdot) \rangle_{\mathcal{H}}]\tag{11}$$

$$= \langle f(\cdot), \mathbb{E}_{q(\mathbf{x})} [k(\mathbf{x}, \cdot) \nabla_{\mathbf{x}} \log p(\mathbf{x}) + \nabla_{\mathbf{x}} k(\mathbf{x}, \cdot)] \rangle_{\mathcal{H}}\tag{12}$$

$$= \langle f(\cdot), \mathbb{E}_{q(\mathbf{x})} [\mathcal{A}_p k(\mathbf{x}, \cdot)] \rangle_{\mathcal{H}}\tag{13}$$

$$= \langle f(\cdot), \beta_{q,p}(\cdot) \rangle_{\mathcal{H}},\tag{14}$$

equation 12 holds because of the linearity of expectation and inner product operation, in equation 14 we define $\beta_{q,p}(\cdot) = \mathbb{E}_{q(\mathbf{x})} [\mathcal{A}_p k(\mathbf{x}, \cdot)]$, and similar to equation 6, we have the optimal solution to equation 7:

$$f^*(\cdot) = \beta_{q,p}(\cdot) / \|\beta_{q,p}(\cdot)\|_{\mathcal{H}},\tag{15}$$

and $\sqrt{S(q, p)} = \|\beta_{q, p}(\cdot)\|_{\mathcal{H}}$, $S(q, p) = \|\beta_{q, p}(\cdot)\|_{\mathcal{H}}^2$. Thus, we have:

$$S(q, p) = \langle \beta_{q, p}(\cdot), \beta_{q, p}(\cdot) \rangle_{\mathcal{H}} \quad (16)$$

$$= \langle \mathbb{E}_{\mathbf{x} \sim q} [\mathcal{A}_p k(\mathbf{x}, \cdot)], \mathbb{E}_{\mathbf{x}' \sim q} [\mathcal{A}_p k(\mathbf{x}', \cdot)] \rangle_{\mathcal{H}} \quad (17)$$

$$= \langle \mathbb{E}_{\mathbf{x} \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x}))k(\mathbf{x}, \cdot)], \mathbb{E}_{\mathbf{x}' \sim q} [(s_p(\mathbf{x}') - s_q(\mathbf{x}'))k(\mathbf{x}', \cdot)] \rangle_{\mathcal{H}} \quad (18)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} \left[(s_p(\mathbf{x}) - s_q(\mathbf{x}))^\top \underbrace{k(\mathbf{x}, \mathbf{x}') (s_p(\mathbf{x}') - s_q(\mathbf{x}'))}_{\textcircled{1}} \right], \quad (19)$$

we use $s_p(\mathbf{x})$ in equation 18 to denote $\nabla_{\mathbf{x}} \log p(\mathbf{x})$, and the equality holds because of Lemma 1. The form in equation 19 still contains the intractable $s_q(\cdot)$, we will further make it computationally tractable.

First, note that we can apply Lemma 1 to $\textcircled{1}$ in equation 19 by keeping \mathbf{x} fixed (denote $k(\mathbf{x}, \mathbf{x}') = k_{\mathbf{x}}(\mathbf{x}')$ in this case), then we have:

$$\mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x}))^\top k_{\mathbf{x}}(\mathbf{x}') (s_p(\mathbf{x}') - s_q(\mathbf{x}'))] \quad (20)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x}))^\top \mathcal{A}_p k_{\mathbf{x}}(\mathbf{x}')] \quad (21)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x}))^\top (k_{\mathbf{x}}(\mathbf{x}') \nabla_{\mathbf{x}'} \log p(\mathbf{x}') + \nabla_{\mathbf{x}'} k_{\mathbf{x}}(\mathbf{x}'))] \quad (22)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x}))^\top v(\mathbf{x}, \mathbf{x}')], \quad (23)$$

where we denote $v(\mathbf{x}, \mathbf{x}') = \mathcal{A}_p^{\mathbf{x}'} k_{\mathbf{x}}(\mathbf{x}') = k_{\mathbf{x}}(\mathbf{x}') \nabla_{\mathbf{x}'} \log p(\mathbf{x}') + \nabla_{\mathbf{x}'} k_{\mathbf{x}}(\mathbf{x}') \in \mathbb{R}^d$, and $v_{\mathbf{x}'}(\mathbf{x})$ is also in the Stein class, thus Lemma 2 is applicable to equation 23, and we can have:

$$\mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x}))^\top v_{\mathbf{x}'}(\mathbf{x})] \quad (24)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [\text{trace}(\mathcal{A}_p^{\mathbf{x}} v_{\mathbf{x}'}(\mathbf{x}))] \quad (25)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [\text{trace}(\mathcal{A}_p^{\mathbf{x}} \mathcal{A}_p^{\mathbf{x}'} k(\mathbf{x}, \mathbf{x}'))] \quad (26)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [\text{trace}(\nabla_{\mathbf{x}} \log p(\mathbf{x}) v_{\mathbf{x}'}(\mathbf{x})^\top + \nabla_{\mathbf{x}} v_{\mathbf{x}'}(\mathbf{x}))] \quad (27)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [\text{trace}(\nabla_{\mathbf{x}} \log p(\mathbf{x})^\top v_{\mathbf{x}'}(\mathbf{x})) + \text{trace}(\nabla_{\mathbf{x}} v_{\mathbf{x}'}(\mathbf{x}))], \quad (28)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [s_p(\mathbf{x})^\top k(\mathbf{x}, \mathbf{x}') s_p(\mathbf{x}') + s_p(\mathbf{x})^\top \nabla_{\mathbf{x}'} k(\mathbf{x}, \mathbf{x}') + \text{trace}(\nabla_{\mathbf{x}} k(\mathbf{x}, \mathbf{x}') s_p(\mathbf{x}')^\top) + \text{trace}(\nabla_{\mathbf{x}} \nabla_{\mathbf{x}'} k(\mathbf{x}, \mathbf{x}'))] \quad (29)$$

$$= \mathbb{E}_{\mathbf{x}, \mathbf{x}' \sim q} [s_p(\mathbf{x})^\top k(\mathbf{x}, \mathbf{x}') s_p(\mathbf{x}') + s_p(\mathbf{x})^\top \nabla_{\mathbf{x}'} k(\mathbf{x}, \mathbf{x}') + s_p(\mathbf{x}')^\top \nabla_{\mathbf{x}} k(\mathbf{x}, \mathbf{x}') + \text{trace}(\nabla_{\mathbf{x}} \nabla_{\mathbf{x}'} k(\mathbf{x}, \mathbf{x}'))], \quad (30)$$

now the intractable $s_q(\mathbf{x})$ terms are removed from the formulation of KSD.

2 Stein Variational Gradient Descent

2.1 Multi-dimensional KSD

In the following, we will consider data points take values in $\mathcal{X} \subset \mathbb{R}^d$ and $\phi : \mathcal{X} \rightarrow \mathbb{R}^d$. We can apply the Stein identity in equation 1 again by taking $\phi(\mathbf{x})$ as the $f(\mathbf{x})$, a tiny difference is now $\mathbf{x} \in \mathbb{R}^d$ and $\phi(\mathbf{x}) = [\phi_1(\mathbf{x}), \dots, \phi_d(\mathbf{x})]^\top$ are both d -dimensional vectors, and $\mathcal{A}_p \phi(\mathbf{x}) = \phi(\mathbf{x}) \nabla_{\mathbf{x}} \log p(\mathbf{x})^\top + \nabla_{\mathbf{x}} \phi(\mathbf{x}) \in \mathbb{R}^{d \times d}$. We will also use \mathcal{H}^d to denote the space of vector functions $\mathbf{f} = [f_1, \dots, f_d]$ with $f_d \in \mathcal{H}$, whose inner product is given by $\langle \mathbf{f}, \mathbf{g} \rangle_{\mathcal{H}^d} = \sum_{i=1}^d \langle f_i, g_i \rangle_{\mathcal{H}}$. And the Stein discrepancy which searches the ϕ in the RKHS \mathcal{H}^d is given by:

$$\sqrt{S(q, p)} = \max_{\phi \in \mathcal{H}^d} \{\mathbb{E}_{\mathbf{x} \sim q} [\text{trace}(\mathcal{A}_p \phi(\mathbf{x}))]\} \quad \text{s.t.} \quad \|\phi\|_{\mathcal{H}^d} \leq 1, \quad (31)$$

and the objective of equation 31 can be further written as:

$$\mathbb{E}_{q(\mathbf{x})} [\text{trace}(\mathcal{A}_p \phi(\mathbf{x}))] \quad (32)$$

$$= \mathbb{E}_{q(\mathbf{x})} [\text{trace}(\phi(\mathbf{x}) \nabla_{\mathbf{x}} \log p(\mathbf{x})^\top) + \text{trace}(\nabla_{\mathbf{x}} \phi(\mathbf{x}))] \quad (33)$$

$$= \mathbb{E}_{q(\mathbf{x})} \left[\sum_{i=1}^d \left(\frac{\partial}{\partial \mathbf{x}_i} \phi_i(\mathbf{x}) + \frac{\partial}{\partial \mathbf{x}_i} \log p(\mathbf{x}) \phi_i(\mathbf{x}) \right) \right], \quad (34)$$

and since every $\phi_i(\cdot)$ comes from the RKHS with reproducing kernel $k(\cdot, \cdot)$, by the reproducing property we can have:

$$\phi_i(\mathbf{x}) = \langle \phi_i(\cdot), k(\mathbf{x}, \cdot) \rangle_{\mathcal{H}}, \quad (35)$$

$$\frac{\partial}{\partial \mathbf{x}_i} \phi_i(\mathbf{x}) = \langle \phi_i(\cdot), \frac{\partial}{\partial \mathbf{x}_i} k(\mathbf{x}, \cdot) \rangle_{\mathcal{H}}, \quad (36)$$

thus equation 34 can be further derived as:

$$\mathbb{E}_{q(\mathbf{x})} \left[\sum_{i=1}^d \left(\frac{\partial}{\partial \mathbf{x}_i} \phi_i(\mathbf{x}) + \frac{\partial}{\partial \mathbf{x}_i} \log p(\mathbf{x}) \phi_i(\mathbf{x}) \right) \right] \quad (37)$$

$$= \sum_{i=1}^d \langle \phi_i(\cdot), \mathbb{E}_{q(\mathbf{x})} \left[\frac{\partial}{\partial \mathbf{x}_i} \log p(\mathbf{x}) k(\mathbf{x}, \cdot) + \frac{\partial}{\partial \mathbf{x}_i} k(\mathbf{x}, \cdot) \right] \rangle_{\mathcal{H}}, \quad (38)$$

the optimal unnormalized $\tilde{\phi}(\cdot)$ is given by simply setting its i -th entry to $\mathbb{E}_{q(\mathbf{x})} \left[\frac{\partial}{\partial \mathbf{x}_i} \log p(\mathbf{x}) k(\mathbf{x}, \cdot) + \frac{\partial}{\partial \mathbf{x}_i} k(\mathbf{x}, \cdot) \right]$, which means $\tilde{\phi}^*(\cdot) = \mathbb{E}_{q(\mathbf{x})} [\mathcal{A}_p k(\mathbf{x}, \cdot)]$ (note that $\mathcal{A}_p k(\mathbf{x}, \cdot) \in \mathbb{R}^d$) and $\phi^*(\mathbf{x}) = \tilde{\phi}^*(\mathbf{x}) / \|\tilde{\phi}^*(\cdot)\|_{\mathcal{H}^d}$.

2.2 Variational inference with smooth transforms

The general idea of Stein Variational Gradient Descent (SVGD) [Liu and Wang, 2016] is incrementally transforming a set of data points $\{\mathbf{x}_i\}_{i=1}^n, \mathbf{x}_i \in \mathbb{R}^d$ sampled from a known initial distribution $q(\mathbf{x})$ to approximate a target distribution $p(\mathbf{x}) = \tilde{p}(\mathbf{x})/Z$ which may be unnormalized. The transformation is in the form of: $\mathbf{T}(\mathbf{x}) = \mathbf{x} + \epsilon \phi(\mathbf{x})$, where $\phi(\mathbf{x}) \in \mathbb{R}^d$ is a smooth function that characterizes the direction and the scalar ϵ represents the magnitude.

Denote $q_{[\mathbf{T}]}$ as the density of the transformed points, when $|\epsilon|$ is sufficiently small, \mathbf{T} is guaranteed to be invertible, and denote $\mathbf{z} = \mathbf{T}(\mathbf{x})$, we have:

$$q_{[\mathbf{T}]}(\mathbf{z}) = q(\mathbf{T}^{-1}(\mathbf{z})) |\det(J_{\mathbf{T}^{-1}}(\mathbf{z}))|. \quad (39)$$

SVGD proposes to use $q_{[\mathbf{T}]}(\mathbf{z})$ to do variational inference by updating the particles to get close to $p(\mathbf{x})$ in terms of KL divergence. And there is a surprising connection between *Stein operator* and the derivative of KL divergence w.r.t. the perturbation magnitude ϵ :

$$\nabla_{\epsilon} D_{\text{KL}}(q_{[\mathbf{T}]} \| p) \Big|_{\epsilon=0} \quad (40)$$

$$= \nabla_{\epsilon} D_{\text{KL}}(q \| p_{[\mathbf{T}^{-1}]}) \Big|_{\epsilon=0} \quad (41)$$

$$= \mathbb{E}_{\mathbf{x} \sim q} [-\nabla_{\epsilon} \log p_{[\mathbf{T}^{-1}]}(\mathbf{x})] \Big|_{\epsilon=0} \quad (42)$$

$$= \mathbb{E}_{\mathbf{x} \sim q} [-\nabla_{\epsilon} (\log p(\mathbf{T}_{\epsilon}(\mathbf{x})) + \log |\det J_{\mathbf{T}}(\mathbf{x})|)] \Big|_{\epsilon=0} \quad (43)$$

$$= -\mathbb{E}_{\mathbf{x} \sim q} [s_p(\mathbf{T}_{\epsilon}(\mathbf{x}))^\top \nabla_{\epsilon} \mathbf{T}_{\epsilon}(\mathbf{x}) + \text{trace}(J_{\mathbf{T}}(\mathbf{x})^{-1} \nabla_{\epsilon} J_{\mathbf{T}}(\mathbf{x}))] \Big|_{\epsilon=0} \quad (44)$$

$$= -\mathbb{E}_{\mathbf{x} \sim q} [s_p(\mathbf{x})^\top \phi(\mathbf{x}) + \text{trace}(\mathbf{I} \nabla_{\mathbf{x}} \phi(\mathbf{x}))] \quad (45)$$

$$= -\mathbb{E}_{\mathbf{x} \sim q} [\text{trace}(\mathcal{A}_p \phi(\mathbf{x}))]. \quad (46)$$

We can see it is equivalent to the objective in equation 31, and when we consider $\phi(\cdot)$ in the unit ball of \mathcal{H}^d , the optimal direction that gives **the steepest descent on the KL divergence** has a closed form solution as $\phi_{q,p}^*(\cdot) = \beta_{q,p}(\cdot) = \mathbb{E}_{\mathbf{x} \sim q} [\mathcal{A}_p k(\mathbf{x}, \cdot)] = \mathbb{E}_{\mathbf{x} \sim q} [\nabla_{\mathbf{x}} \log p(\mathbf{x}) k(\mathbf{x}, \cdot) + \nabla_{\mathbf{x}} k(\mathbf{x}, \cdot)]$, this is computationally tractable.

3 Amortized SVGD

"SVGD and other particle based methods become inefficient when we need to apply them repeatedly on a large number of different, but similar target distributions for multiple tasks, because they can not leverage the similarity between the different distributions and may require a large memory to store a large number of particles."

References

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A The reproducing property

Refer to [Sejdinovic and Gretton, 2012].

B Lemmas

Lemma 1 (First half of Lemma 2.3 of [Liu et al., 2016]). Assume $p(\mathbf{x})$ and $q(\mathbf{x})$ are smooth densities supported on \mathcal{X} and **scalar-valued** function $f(\mathbf{x})$ is in the Stein class of q , we have:

$$\mathbb{E}_{\mathbf{x} \sim q} [\mathcal{A}_p f(\mathbf{x})] = \mathbb{E}_{\mathbf{x} \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x})) f(\mathbf{x})].$$

Lemma 2 (Second half of Lemma 2.3 of [Liu et al., 2016]). Assume $p(\mathbf{x})$ and $q(\mathbf{x})$ are smooth densities supported on \mathcal{X} and when $\mathbf{f}(\mathbf{x})$ is a $d \times 1$ **vector-valued** function in the Stein class of q , we have:

$$\mathbb{E}_{\mathbf{x} \sim q} [(s_p(\mathbf{x}) - s_q(\mathbf{x}))^\top \mathbf{f}(\mathbf{x})] = \mathbb{E}_{\mathbf{x} \sim q} [\text{trace}(\mathcal{A}_p \mathbf{f}(\mathbf{x}))].$$

C Introduction to measure theory

- Limit of a sequence: a sequence x_1, x_2, \dots, x_n is said to converge to x or have limit if ...
- Cauchy sequence

- Algebraic structure
- measure space: $(\mathcal{X}, \mathcal{A}, \mu)$, where \mathcal{X} is a set, \mathcal{A} is a class of subsets of \mathcal{X} , and μ is a function that attach a nonnegative number to every set in \mathcal{A} .
- σ -algebra: \mathcal{A} is call a σ -field of \mathcal{X} if:
 - both \emptyset and \mathcal{X} in \mathcal{A}
 - if A in \mathcal{A} , then A^c in \mathcal{A}
 - if A_1, \dots, A_n is a countable collection of sets in \mathcal{A} , then both $\cup_i A_i$ and $\cap_i A_i$ in \mathcal{A}
- measure: a function μ defined on \mathcal{A} is called a (countably additive, nonnegative) measure if: (1) (2) (3)
- $(\Omega, \mathcal{F}, \mathbb{P})$ used to denote a probability space
- countable additive
- metric space, complete metric space, normed space
- inner product on a vector space
- Hilbert space: a vector space where inner product is defined, and contains all the limits of Cauchy sequences of functions
- kernel: $k : \mathcal{X} \times \mathcal{X} \rightarrow \mathbb{R}$ is a kernel if exists a \mathbb{R} -Hilbert space and a map $\phi : \mathcal{X} \rightarrow \mathcal{H}$ s.t. $k(x, x') = \langle \phi(x), \phi(x') \rangle_{\mathcal{H}}, \forall x, x' \in \mathcal{X}$